Application No. U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. Substitute Form PTO-1449 (Modified) . 06975-467001 10/747,652 Applicant **Information Disclosure Statement** Patrick Blattner et al. by Applicant (Use several sheets if necessary) Filing Date Group Art Unit 2174 December 30, 2003 (37 CFR §1.98(b))

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Examiner Signature	/Thanh Vu/ (08/22/2007)	Date Considered	
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